Analytical Reference Materials International



Provisional Certificate of Analysis Certified Reference Material



Grade: **Ti Grade 7 / UNS R52400**Part Number (Q.A. NO.): **IARM 303B**

Certificate Date: 07/05/2017 Certificate No.: 303B-07052017-IARM-P Revision Date: 08/28/2017

Interpretation of Data

- 1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community and are reported as % wt. unless otherwise noted.
- 2. Any data reported and enclosed by a **parentheses** () is a "best estimate" and is **NOT CERTIFIED**. This data could not be quantified sufficiently for certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
- 3. The "Inter laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in **brackets** [] **indicates further testing is in process.**Chips are not certified for Hydrogen, Nitrogen, or Oxygen analysis.
- 4. The "**±Estimated Uncertainty**" is enclosed by a **parentheses** () **below** the individual **element's concentration** and is based on a Confidence Interval at 95%. Included in this estimated uncertainty, are the combined effects of method imprecision, material inhomogeneity, and any bias between methods.

Important: A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

Aluminum	Boron	Carbon	Chromium	Cobalt	Copper	<u>Hafnium</u>	Hydrogen	<u>Iron</u>
[0.015]	[(<0.001)]	[0.035]	[0.0018]	[(<0.002)]	[0.002]	[(<0.003)]	[0.0008]	[0.120]
[(0.005)]		[(0.003)]	[(0.0006)]		[(0.002)]		[(0.0005)]	[(0.007)]
Magnesium	Manganese	Molybdenum	<u>Nickel</u>	Niobium	Nitrogen	Oxygen	Palladium	Phosphorus
[(<0.001)]	[0.001]	[0.002]	[0.0013]	[0.006]	[0.017]	[0.176]	[0.13]	[(<0.002)]
	[(0.001)]	[(0.001)]	[(8000.0)]	[(0.003)]	[(0.004)]	[(0.004)]	[(0.01)]	
Ruthenium	Silicon	<u>Sulfur</u>	<u>Tantalum</u>	<u>Tin</u>	Titanium	Tungsten	Vanadium	Yttrium
[(<0.01)]	[0.006]	[(<0.002)]	[(<0.005)]	[0.006]	[(99.6)]	[(<0.002)]	[0.0023]	[(<0.001)]
	[(0.002)]			[(0.003)]			[(0.0009)]	
Zirconium								
[0.0028]								
[(80008)]								

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

Anderson Laboratories, Inc. - Greendale, WI

Oxford Instruments Analytical GmbH - Uedem, Germany

ATI Richland Operations - Richland, WA

Perryman Company - Houston, PA

Exova - Middlesbrough, UK

Special Metals IncoTest - Hereford, UK

Exova Burlington Lab - Burlington, ON

Timet Savoie - Ugine, France

Laboratory Testing, Inc. - Hatfield, PA

Xi'an Aerospace New Material Co., Ltd. - Shanxii, China

Laboratory Testing, Inc. - Hatrield, I A

Leco Corporation - St. Joseph, MI

ty: All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are:

ALPHA AR637	BCS 356	GBW 02501	IARM 271A	LECO 501-320	LECO 501-674	MBH 101XTI1	NIST 166C	NIST 651
ALPHA AR641	BCS 457/2	HO73	IARM 285A	LECO 501-635	LECO 501-676	MBH 101XTI2	NIST 173	NIST 652
ALPHA AR650	BCS 462/1	IARM 174A	IARM 286A	LECO 501-653	LECO 501-995	MBH 101XTI3	NIST 173C	W68B
ALPHA AR651	BS T13	IARM 175D	IARM 303A	LECO 501-657	LECO 502-135	MBH 101XTI4	NIST 174	
BCR 024	BS T-80	IARM 177B	IARM 312B	LECO 501-664	LECO 502-201	MBH 101XTI5	NIST 648	
BCR 059	RS T-81	IARM 269A	TH ALL VAC BN3849	LECO 501-673	MRH 101XT14	MRH 101XTI6	NIST 650	

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 07/05/2017.

303B	Al	В	С	Cr	Co	Cu	Hf	Н	Fe	Mg	Mn	Мо	Ni	Nb	N	0
1	0.001	0.0001	0.0307	0.001	0.0001	0.0004	0.0023	0.00042	0.1035	0.001	0.0002	0.001	0.0004	0.002	0.0062	0.164
2	0.0042	0.0006	0.0312	0.001	0.0012	0.0009		0.0005	0.1091	< 0.0005	0.0004	0.0012	0.0006	0.002	0.0115	0.173
3	0.012	0.001	0.032	0.0015	0.0013	0.001		0.0005	0.11		0.0004	0.0016	0.001	0.0038	0.0127	0.1745
4	0.0139	< 0.0005	0.0323	0.002	< 0.0010	0.0014		0.0006	0.111		0.0007	0.0019	0.001	0.0043	0.01752	0.176
5	0.014	< 0.0010	0.03338	0.002		0.0016		0.0013	0.114		0.001	0.0026	0.0014	0.0047	0.0176	0.1766
6	0.0185		0.035	0.0022		0.0018		0.0015	0.1189		0.0023	0.0026	0.0019	0.006	0.0185	0.1767
7	0.019		0.0369	0.0026		0.004			0.1192		0.0035	0.0042	0.0029	0.0063	0.02	0.17786
8	0.0192		0.037			0.0053			0.12					0.0105	0.0204	0.1802
9	0.0213		0.039			0.0056			0.1217					0.014	0.0204	0.184
10	0.0226		0.0418						0.1329						0.028	
11	0.0226								0.135							
12									0.1398							
13																
14																
15																
Mean	0.015	0.001	0.035	0.0018	0.001	0.002	0.0023	0.0008	0.120	0.001	0.001	0.002	0.0013	0.006	0.017	0.176
STDV.	0.007	0.000	0.004	0.0006	0.001	0.002		0.0005	0.011		0.001	0.001	0.0009	0.004	0.006	0.005
Certified	0.015	(<0.001)	0.035	0.0018	(<0.002)	0.002	(<0.003)	0.0008	0.120	(<0.001)	0.001	0.002	0.0013	0.006	0.017	0.176
95% C.I.	0.005		0.003	0.0006		0.002		0.0005	0.007		0.001	0.001	0.0008	0.003	0.004	0.004
Methods	X,O,I,G	O,I	С	X,O,I	X,I	X,O,I	1	F	X,O,I,G	1	X,O	X,O,I	X,O,I	X,O,I	F	F

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

303B	Pd	Р	Ru	Si	S	Ta	Sn	Ti	W	V	Y	Zr		
1	0.108	0.0011	0.0007	0.0024	0.0001	0.0003	0.002	99.6	0.0016	0.001	0.0001	0.001		
2	0.1215	< 0.001	0.0009	0.0041	0.0011	0.0008	0.0027	99.69	0.0017	0.0015	0.0006	0.002		
3	0.122		0.004	0.0042	0.0011	< 0.0010	0.0034		< 0.0010	0.0016	0.0007	0.0023		
4	0.125		0.0083	0.005	0.00132	< 0.005	0.0065			0.002	< 0.0010	0.0023		
5	0.132335			0.0066		< 0.005	0.0068			0.002		0.0027		
6	0.1333			0.0078			0.0071			0.0022		0.0028		
7	0.14			0.0088			0.01			0.0036		0.0034		
8							0.0101			0.0043		0.0037		
9												0.0046		
10														
11														
12														
13														
14														
15														
Mean	0.13	0.001	0.003	0.006	0.001	0.001	0.006	99.6	0.002	0.0023	0.0005	0.0028		
STDV.	0.01		0.004	0.002	0.001	0.000	0.003	0.1	0.000	0.0011	0.0003	0.0010		
Certified	0.13	(<0.002)	(<0.01)	0.006	(<0.002)	(<0.005)	0.006	(99.6)	(<0.002)	0.0023	(<0.001)	0.0028		
95% C.I.	0.01			0.002			0.003			0.0009		0.0008		
Methods	X,O,I		X,O,IM,I	X,O,I	С	X,O,I	X,O,I	0	X,I	X,O,I	I	X,O,I		

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1992 list the following:

Certifying Body: Any technically competent body (organization or firm, public or private) that issues a reference material certificate, which provides the information, detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards - Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

Reference Material (RM): Material or substance one or more of whose property values are sufficiently homogeneous and well established to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

Certified Reference Material (CRM): Reference material, accompanied by a certificate, one or more of whose property values are certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

Inter-Laboratory Analysis Program (ILAP): Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol, and treatment of data resulting from this inter laboratory program were performed utilizing the guidelines established in ASTM E691-87.

Methods of Analysis: In view of the fact, that the "Inter Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen, and Oxygen are the result of combustion and OE instrument procedures.

Expiration of Certification: The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Instructions for Use: The test surface is the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing as these processes may contaminate the surface. When not in use, the material should be stored in a cool, dry location. This material was tested using both the solid disks and chips prepared from the disks. The certified values are considered representative of the overall average composition of the material. Chips are not certified for Hydrogen, Nitrogen, or Oxygen analysis.

Selection of Materials: A "batch" or "series" is defined as a single bar of one continuous length and heat. The majority of materials are in wrought condition; other methods of manufacture are utilized as a less desirable resort. ILAP samples are taken by removing a section, a minimum of, every one-twelfth of total length from the entire bar. A portion of the section is converted to chips and thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis. This systematic sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data. This method of homogeneity testing is in accordance with ISO Guide 34, regarding the systematic selection and testing of a representative number of units for the assessment of homogeneity.

David Coler, General Manager

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